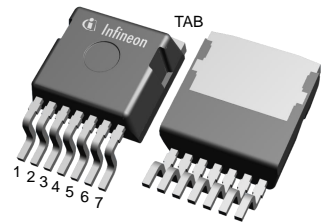


CoolSiC™ 1200 V SiC Trench MOSFET : Silicon Carbide MOSFET

Features

- $V_{DS} = 1200\text{ V}$ at $T_{vj} = -55...175\text{ °C}$
- $I_{DC} = 38\text{ A}$ at $T_C = 25\text{ °C}$
- $R_{DS(on)} = 60\text{ m}\Omega$ at $V_{GS} = 20\text{ V}$, $T_{vj} = 25\text{ °C}$
- New performance-optimized chip technology (Gen1p) with improved $R_{DS(on)}$ * A FOM
- Best in class switching energy for lower switching losses and reduced cooling efforts
- Lowest device capacitances for higher switching speeds and higher power density
- A combination of low C_{rSS}/C_{iSS} ratio and high $V_{GS(th)}$ to avoid parasitic turn-on and enable unipolar gate driving
- Reduced total gate charge Q_{Gtot} for lower driving power and losses
- Increased recommended turn-on voltage ($V_{GS(on)} = 20\text{ V}$) for lower $R_{DS(on)}$
- .XT die attach technology for best in class thermal performance
- Low package stray inductance for faster and cleaner switching
- Sense (Kelvin) source pin for better gate control and reduced switching losses
- Minimal creepage distance 5.85 mm (material group II) to fit 800 V applications without coating
- SMT package for automated assembly and reduced system costs



Halogen-free



Green



Lead-free



RoHS

Potential applications

- On-board charger
- DC/DC converter
- Auxiliary drives

Product validation

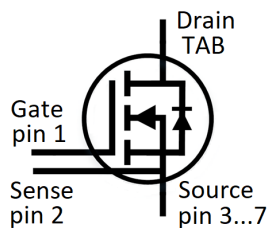
- Qualified for Automotive Applications. Product Validation according to AEC-Q100/101

Description

Pin definition:

- Pin 1 - Gate
- Pin 2 - Kelvin sense contact
- Pin 3...7 - Source
- Tab - Drain

Note: The source and sense pins are not exchangeable, their exchange might lead to malfunction



Type	Package	Marking
AIMBG120R060M1	PG-TO263-7-HV-ND5.8	AS60MM1

Table of contents

	Description	1
	Features	1
	Potential applications	1
	Product validation	1
	Table of contents	2
1	Package	3
2	MOSFET	3
3	Body diode (MOSFET)	6
4	Characteristics diagrams	7
5	Package outlines	12
6	Testing conditions	13
	Revision history	14
	Disclaimer	15

1 Package

Table 1 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Storage temperature	T_{stg}		-55		150	°C
Soldering temperature	T_{sold}				260	°C
MOSFET/body diode thermal resistance, junction-case	$R_{th(j-c)}$			0.57	0.74	K/W

Note: Not subject to production test. Parameter verified by design/characterization.

2 MOSFET

Table 2 Maximum rated values

Parameter	Symbol	Note or test condition	Values	Unit	
Drain-source voltage	V_{DSS}	$T_{vj} = -55...175\text{ °C}$	1200	V	
Continuous DC drain current for $R_{th(j-c,max)}$, limited by $T_{vj(max)}$	I_{DDC}	$V_{GS} = 20\text{ V}$	$T_c = 25\text{ °C}$	38	A
			$T_c = 100\text{ °C}$	27	
Peak drain current, t_p limited by $T_{vj(max)}$	I_{DM}	$V_{GS} = 20\text{ V}$	97	A	
Gate-source voltage, max. transient voltage ¹⁾	V_{GS}	$t_p \leq 0.5\text{ }\mu\text{s}$, $D < 0.01$	-10...25	V	
Gate-source voltage, max. static voltage	V_{GS}		-5...23	V	
Avalanche energy, single pulse	E_{AS}	$I_D = 10\text{ A}$, $V_{DD} = 50\text{ V}$, $L = 3.6\text{ mH}$	180	mJ	
Power dissipation, limited by $T_{vj(max)}$	P_{tot}	$T_c = 25\text{ °C}$	202	W	
		$T_c = 100\text{ °C}$	101		

1) **Important note:** The selection of positive and negative gate-source voltages impacts the long-term behavior of the device. The design guidelines described in Application Note AN2018-09 must be considered to ensure sound operation of the device over the planned lifetime.

Table 3 Recommended values

Parameter	Symbol	Note or test condition	Values	Unit
Recommended turn-on gate voltage	$V_{GS(on)}$		20	V
Recommended turn-off gate voltage	$V_{GS(off)}$		0	V

Table 4 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit	
			Min.	Typ.	Max.		
Drain-source on-state resistance ¹⁾	$R_{DS(on)}$	$I_D = 13\text{ A}$	$T_{vj} = 25\text{ °C}$, $V_{GS(on)} = 20\text{ V}$		60	75	mΩ
			$T_{vj} = 100\text{ °C}$, $V_{GS(on)} = 20\text{ V}$		84		
			$T_{vj} = 175\text{ °C}$, $V_{GS(on)} = 20\text{ V}$		120		
			$T_{vj} = 25\text{ °C}$, $V_{GS(on)} = 18\text{ V}$		63		
Gate-source threshold voltage ¹⁾	$V_{GS(th)}$	$I_D = 4.3\text{ mA}$, $V_{DS} = V_{GS}$ (tested after 1 ms pulse at $V_{GS} = 20\text{ V}$)	$T_{vj} = 25\text{ °C}$	3.5	4.3	5.1	V
			$T_{vj} = 175\text{ °C}$		3.8		
Zero gate-voltage drain current	I_{DSS}	$V_{DS} = 1200\text{ V}$, $V_{GS} = 0\text{ V}$	$T_{vj} = 25\text{ °C}$		0.3	13	μA
			$T_{vj} = 175\text{ °C}$		0.9		
Gate leakage current	I_{GSS}	$V_{DS} = 0\text{ V}$	$V_{GS} = 25\text{ V}$			100	nA
			$V_{GS} = -10\text{ V}$			-100	
Forward transconductance	g_{fs}	$I_D = 13\text{ A}$, $V_{DS} = 20\text{ V}$			11		S
Short-circuit withstand time	t_{SC}	$V_{DD} \leq 800\text{ V}$, $V_{DS,peak} < 1200\text{ V}$, $T_{vj(start)} = 25\text{ °C}$, $R_{G,ext} = 2\text{ }\Omega$	$V_{GS(on)} = 20\text{ V}$		1.5		μs
			$V_{GS(on)} = 18\text{ V}$		2		
			$V_{GS(on)} = 15\text{ V}$		2.5		
Internal gate resistance	$R_{G,int}$	$f = 1\text{ MHz}$, $V_{AC} = 25\text{ mV}$			3.7		Ω
Input capacitance	C_{iss}	$V_{DD} = 800\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 100\text{ kHz}$, $V_{AC} = 25\text{ mV}$			880		pF
Output capacitance	C_{oss}	$V_{DD} = 800\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 100\text{ kHz}$, $V_{AC} = 25\text{ mV}$			43		pF
Reverse transfer capacitance	C_{riss}	$V_{DD} = 800\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 100\text{ kHz}$, $V_{AC} = 25\text{ mV}$			2		pF
C_{oss} stored energy	E_{oss}	$V_{DD} = 800\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 100\text{ kHz}$, $V_{AC} = 25\text{ mV}$			18		μJ
Total gate charge	Q_G	$V_{DD} = 800\text{ V}$, $I_D = 13\text{ A}$, $V_{GS} = 0/20\text{ V}$, turn-on pulse			32		nC
Plateau gate charge	$Q_{GS(pl)}$	$V_{DD} = 800\text{ V}$, $I_D = 13\text{ A}$, $V_{GS} = 0/20\text{ V}$, turn-on pulse			8		nC
Gate-to-drain charge	Q_{GD}	$V_{DD} = 800\text{ V}$, $I_D = 13\text{ A}$, $V_{GS} = 0/20\text{ V}$, turn-on pulse			5		nC
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 800\text{ V}$, $I_D = 13\text{ A}$, $V_{GS} = 0/20\text{ V}$, $R_{GS(on)} = 2\text{ }\Omega$, $R_{GS(off)} = 2\text{ }\Omega$, $L_\sigma = 15\text{ nH}$, diode: body diode at $V_{GS} = 0\text{ V}$	$T_{vj} = 25\text{ °C}$		6		ns
			$T_{vj} = 175\text{ °C}$		8		

(table continues...)

Table 4 (continued) Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Rise time	t_r	$V_{DD} = 800\text{ V}, I_D = 13\text{ A},$ $V_{GS} = 0/20\text{ V},$ $R_{GS(on)} = 2\ \Omega,$ $R_{GS(off)} = 2\ \Omega, L_\sigma = 15\text{ nH},$ diode: body diode at $V_{GS} = 0\text{ V}$	$T_{vj} = 25\text{ }^\circ\text{C}$		6	ns
			$T_{vj} = 175\text{ }^\circ\text{C}$		7	
Turn-off delay time	$t_{d(off)}$	$V_{DD} = 800\text{ V}, I_D = 13\text{ A},$ $V_{GS} = 0/20\text{ V},$ $R_{GS(on)} = 2\ \Omega,$ $R_{GS(off)} = 2\ \Omega, L_\sigma = 15\text{ nH},$ diode: body diode at $V_{GS} = 0\text{ V}$	$T_{vj} = 25\text{ }^\circ\text{C}$		15	ns
			$T_{vj} = 175\text{ }^\circ\text{C}$		16	
Fall time	t_f	$V_{DD} = 800\text{ V}, I_D = 13\text{ A},$ $V_{GS} = 0/20\text{ V},$ $R_{GS(on)} = 2\ \Omega,$ $R_{GS(off)} = 2\ \Omega, L_\sigma = 15\text{ nH},$ diode: body diode at $V_{GS} = 0\text{ V}$	$T_{vj} = 25\text{ }^\circ\text{C}$		10	ns
			$T_{vj} = 175\text{ }^\circ\text{C}$		11	
Turn-on energy	E_{on}	$V_{DD} = 800\text{ V}, I_D = 13\text{ A},$ $V_{GS} = 0/20\text{ V},$ $R_{GS(on)} = 2\ \Omega,$ $R_{GS(off)} = 2\ \Omega, L_\sigma = 15\text{ nH},$ diode: body diode at $V_{GS} = 0\text{ V}$	$T_{vj} = 25\text{ }^\circ\text{C}$		81	μJ
			$T_{vj} = 175\text{ }^\circ\text{C}$		89	
Turn-off energy	E_{off}	$V_{DD} = 800\text{ V}, I_D = 13\text{ A},$ $V_{GS} = 0/20\text{ V},$ $R_{GS(on)} = 2\ \Omega,$ $R_{GS(off)} = 2\ \Omega, L_\sigma = 15\text{ nH},$ diode: body diode at $V_{GS} = 0\text{ V}$	$T_{vj} = 25\text{ }^\circ\text{C}$		42	μJ
			$T_{vj} = 175\text{ }^\circ\text{C}$		43	
Total switching energy	E_{tot}	$V_{DD} = 800\text{ V}, I_D = 13\text{ A},$ $V_{GS} = 0/20\text{ V},$ $R_{GS(on)} = 2\ \Omega,$ $R_{GS(off)} = 2\ \Omega, L_\sigma = 15\text{ nH},$ diode: body diode at $V_{GS} = 0\text{ V}$	$T_{vj} = 25\text{ }^\circ\text{C}$		123	μJ
			$T_{vj} = 175\text{ }^\circ\text{C}$		132	
Virtual junction temperature	T_{vj}			-55	175	$^\circ\text{C}$

1) **Important note:** The selection of positive and negative gate-source voltages impacts the long-term behavior of the device. The design guidelines described in Application Note AN2018-09 must be considered to ensure sound operation of the device over the planned lifetime.

Note: Characteristics at $T_{vj} = 25^\circ\text{C}$, unless otherwise specified.

3 Body diode (MOSFET)

Table 5 Maximum rated values

Parameter	Symbol	Note or test condition	Values	Unit	
Drain-source voltage	V_{DSS}	$T_{vj} = -55...175\text{ °C}$	1200	V	
Continuous reverse drain current for $R_{th(j-c,max)}$, limited by $T_{vj(max)}$	I_{SDC}	$V_{GS} = 0\text{ V}$	$T_c = 25\text{ °C}$	30	A
			$T_c = 100\text{ °C}$	21	
Peak reverse drain current, t_p limited by $T_{vj(max)}$	I_{SM}	$V_{GS} = 0\text{ V}$	30	A	

Table 6 Characteristic values

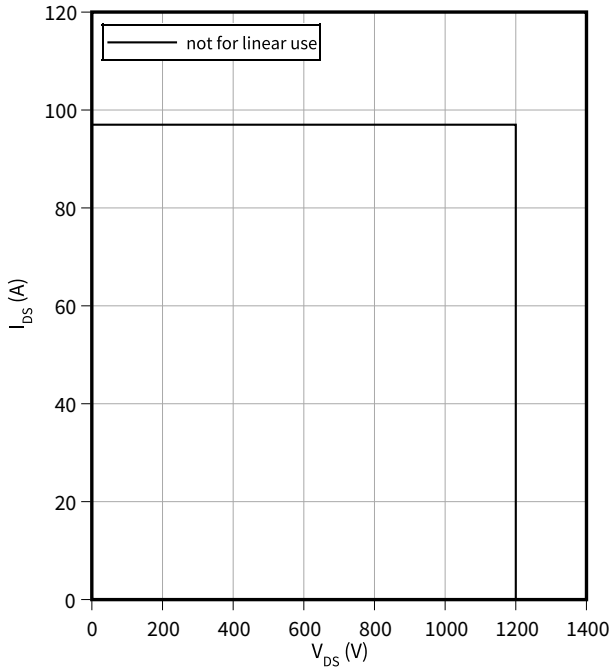
Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Drain-source reverse voltage	V_{SD}	$I_{SD} = 13\text{ A}, V_{GS} = 0\text{ V}$	$T_{vj} = 25\text{ °C}$	3.9	5	V
			$T_{vj} = 100\text{ °C}$	3.8		
			$T_{vj} = 175\text{ °C}$	3.7		
MOSFET forward recovery charge	Q_{fr}	$V_{DD} = 800\text{ V}, I_{SD} = 13\text{ A}, V_{GS} = 0\text{ V}, di_{SD}/dt = 3000\text{ A}/\mu\text{s}, Q_{fr}$ includes also Q_C	$T_{vj} = 25\text{ °C}$	96		nC
			$T_{vj} = 175\text{ °C}$	144		
MOSFET peak forward recovery current	I_{frm}	$V_{DD} = 800\text{ V}, I_{SD} = 13\text{ A}, V_{GS} = 0\text{ V}, di_{SD}/dt = 3000\text{ A}/\mu\text{s}, Q_{fr}$ includes also Q_C	$T_{vj} = 25\text{ °C}$	10		A
			$T_{vj} = 175\text{ °C}$	12		
Virtual junction temperature	T_{vj}		-55		175	°C

4 Characteristics diagrams

Reverse bias safe operating area (RBSOA)

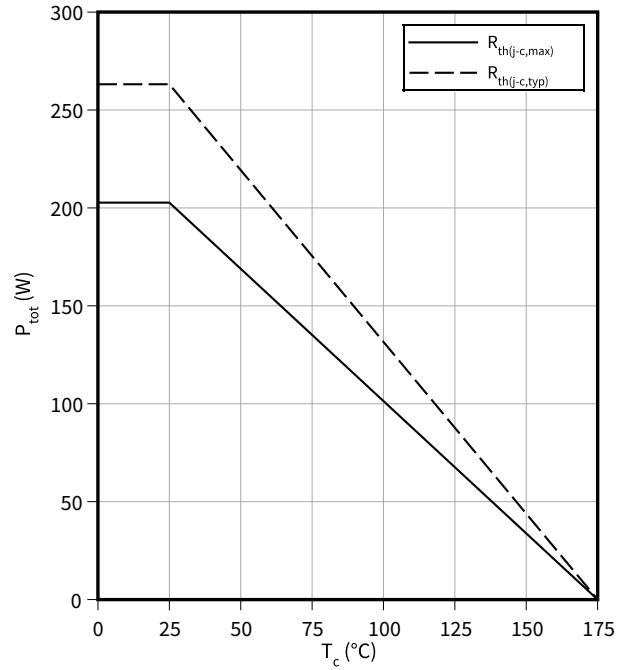
$$I_{DS} = f(V_{DS})$$

$$T_{vj} \leq 175\text{ °C}, V_{GS} = 0/20\text{ V}, T_c = 25\text{ °C}$$



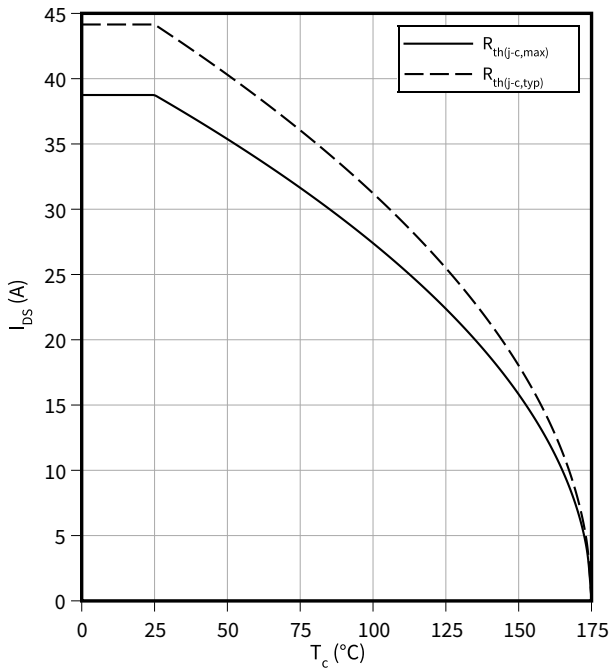
Power dissipation as a function of case temperature

$$P_{tot} = f(T_c)$$



Maximum DC drain to source current as a function of case temperature

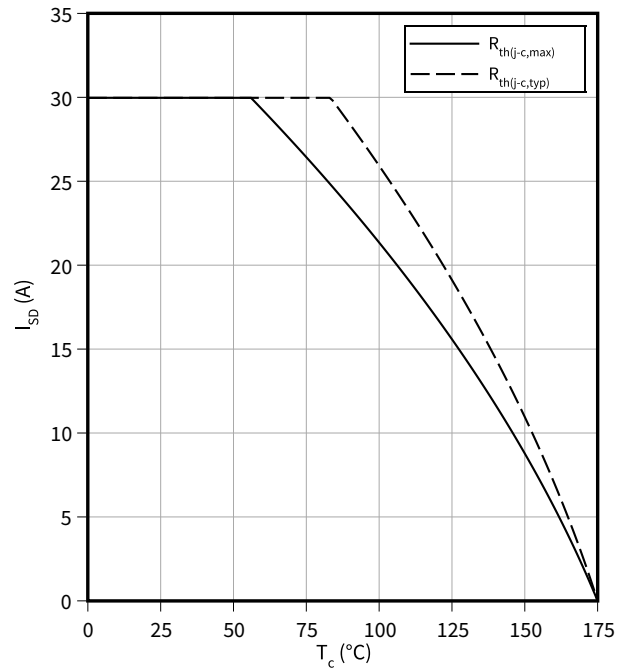
$$I_{DS} = f(T_c)$$



Maximum source to drain current as a function of case temperature

$$I_{SD} = f(T_c)$$

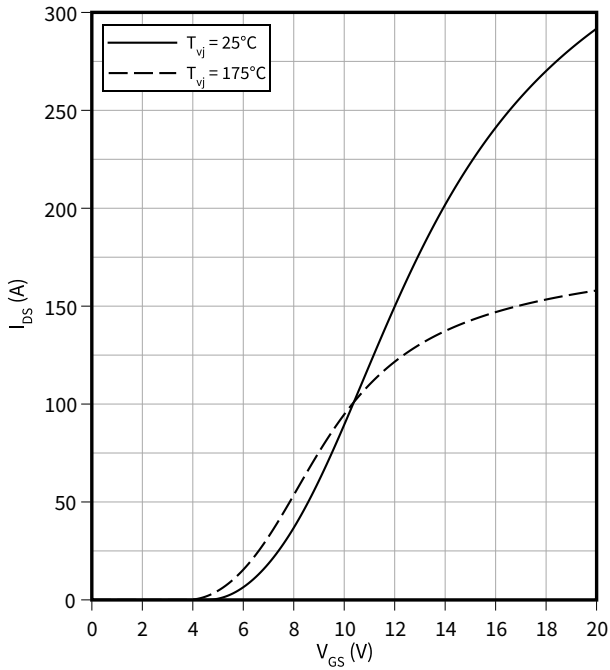
$$V_{GS} = 0\text{ V}$$



4 Characteristics diagrams

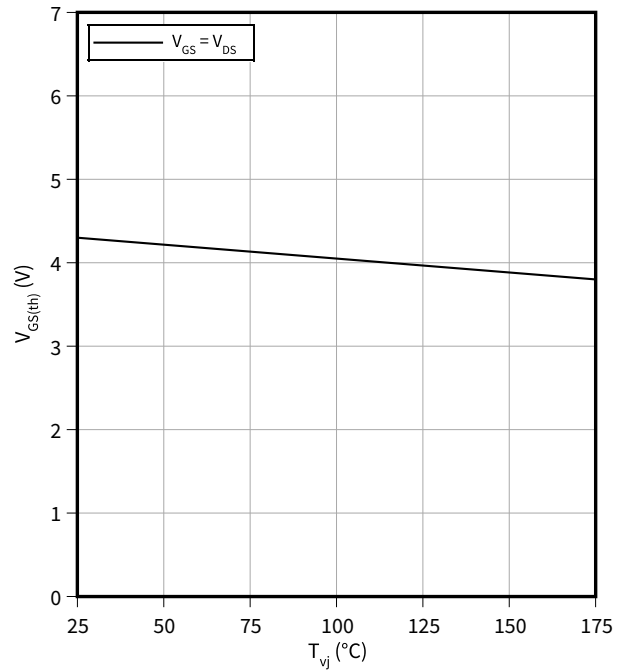
Typical transfer characteristic

$I_{DS} = f(V_{GS})$
 $V_{DS} = 20 \text{ V}$



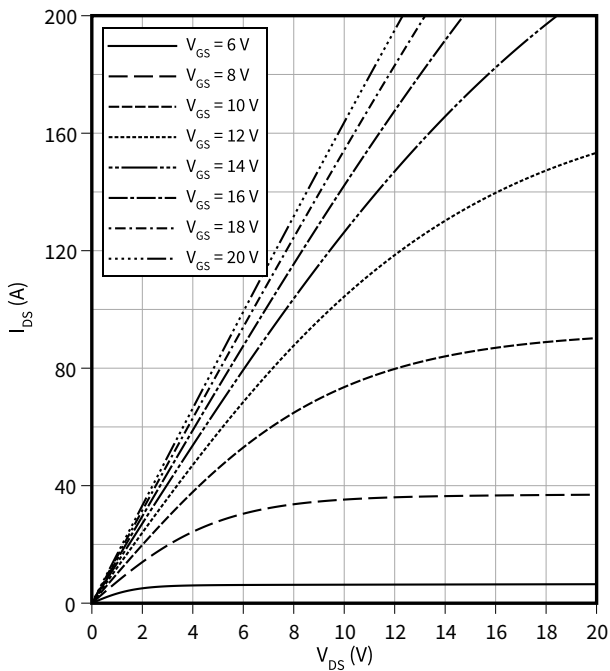
Typical gate-source threshold voltage as a function of junction temperature

$V_{GS(th)} = f(T_{vj})$
 $I_D = 4.3 \text{ mA}$



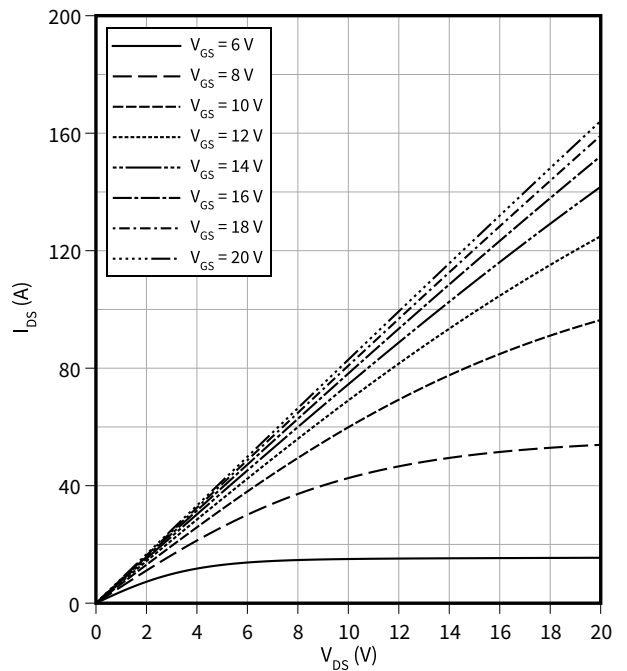
Typical output characteristic, V_{GS} as parameter

$I_{DS} = f(V_{DS})$
 $T_{vj} = 25 \text{ }^\circ\text{C}$



Typical output characteristic, V_{GS} as parameter

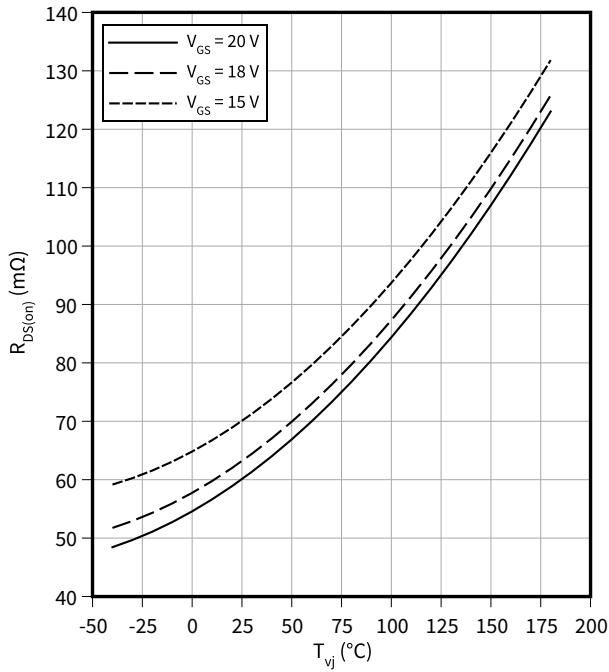
$I_{DS} = f(V_{DS})$
 $T_{vj} = 175 \text{ }^\circ\text{C}$



4 Characteristics diagrams

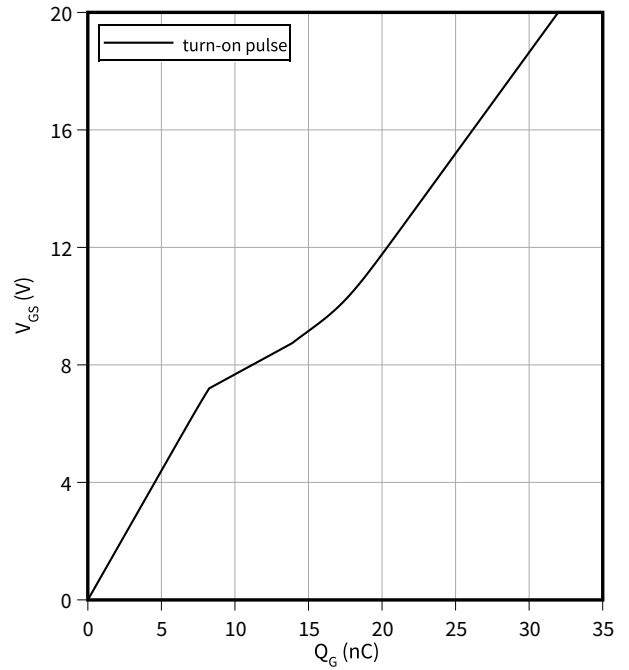
Typical on-state resistance as a function of junction temperature

$R_{DS(on)} = f(T_{vj})$
 $I_D = 13 \text{ A}$



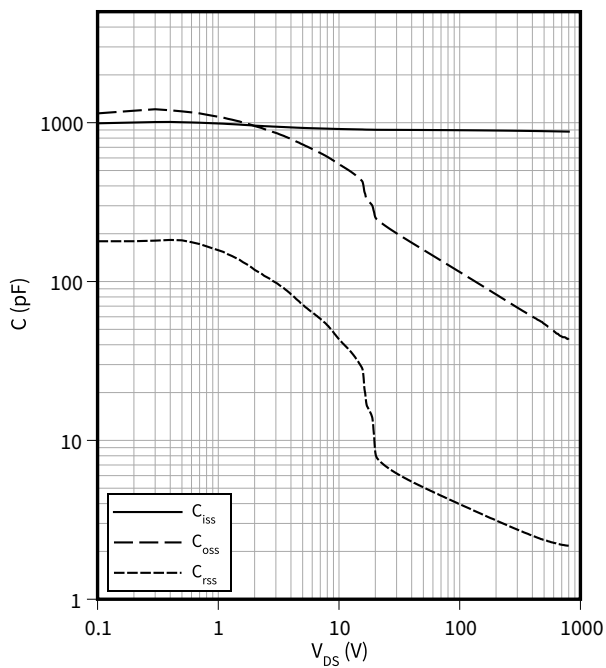
Typical gate charge

$V_{GS} = f(Q_G)$
 $I_D = 13 \text{ A}, V_{DS} = 800 \text{ V}$



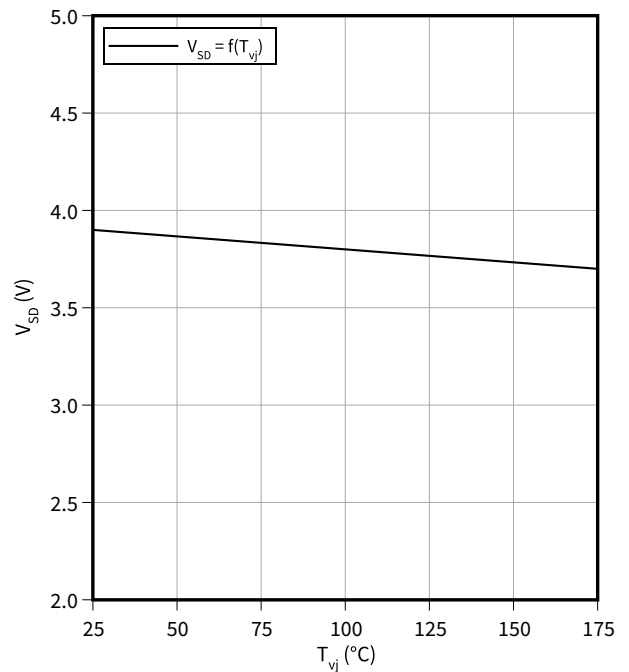
Typical capacitance as a function of drain-source voltage

$C = f(V_{DS})$
 $f = 100 \text{ kHz}, V_{GS} = 0 \text{ V}$



Typical reverse drain voltage as function of junction temperature

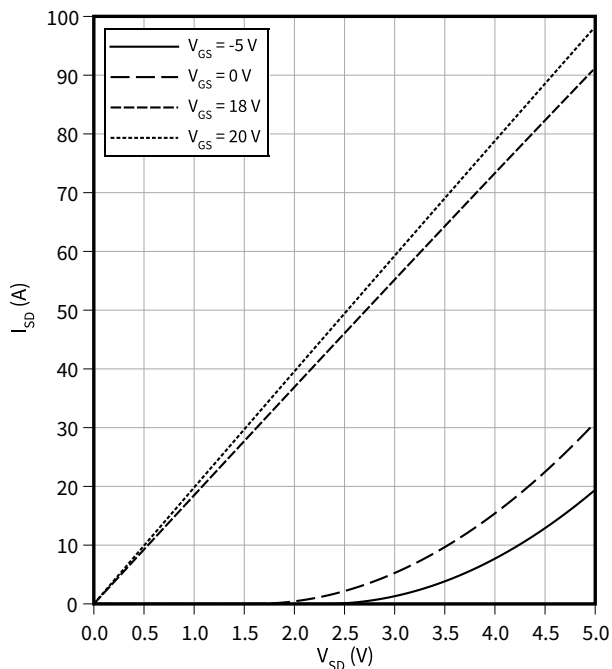
$V_{SD} = f(T_{vj})$
 $I_{SD} = 13 \text{ A}, V_{GS} = 0 \text{ V}$



4 Characteristics diagrams

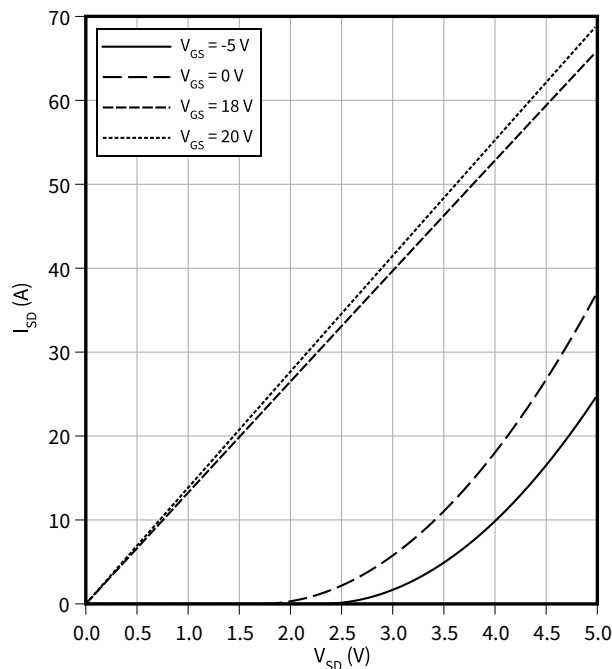
Typical reverse drain current as function of reverse drain voltage, V_{GS} as parameter

$I_{SD} = f(V_{SD})$
 $T_{vj} = 25\text{ °C}$



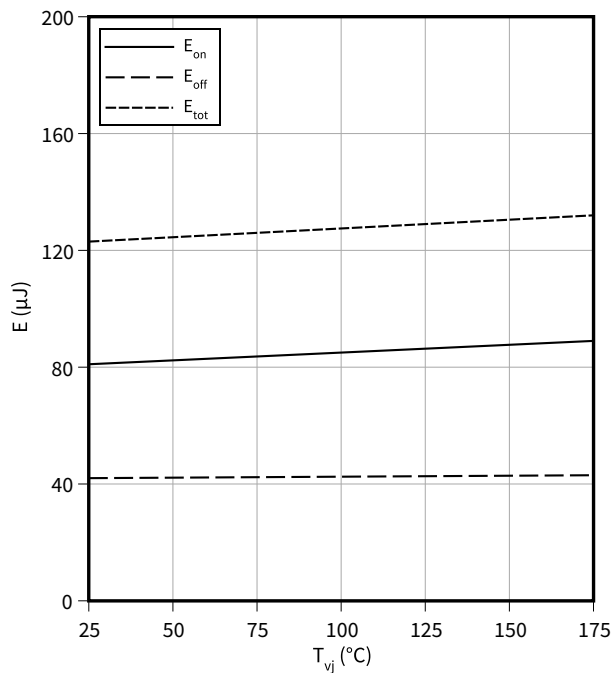
Typical reverse drain current as function of reverse drain voltage, V_{GS} as parameter

$I_{SD} = f(V_{SD})$
 $T_{vj} = 175\text{ °C}$



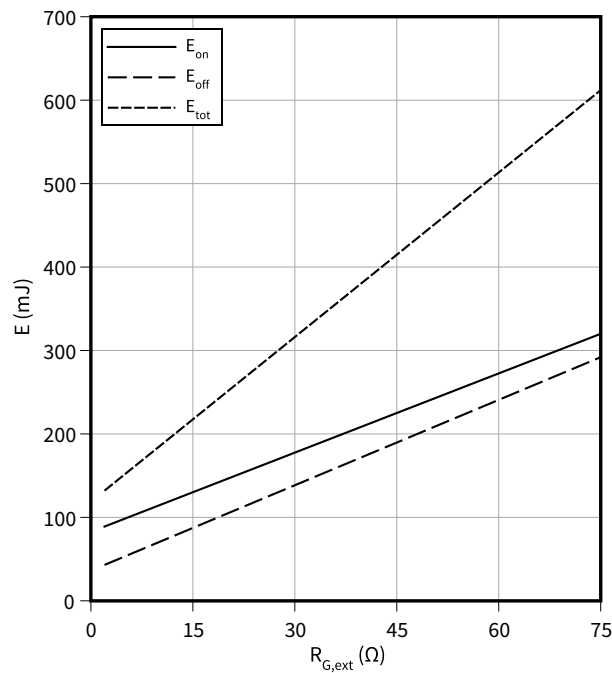
Typical switching energy as a function of junction temperature, test circuit in Fig. F, 2nd device own body diode: $V_{GS} = 0\text{ V}$

$E = f(T_{vj})$
 $V_{GS} = 0/20\text{ V}$, $I_D = 13\text{ A}$, $R_{G,ext} = 2\text{ }\Omega$, $V_{DD} = 800\text{ V}$



Typical switching energy as a function of gate resistance, test circuit in Fig. F, 2nd device own body diode: $V_{GS} = 0\text{ V}$

$E = f(R_{G,ext})$
 $V_{GS} = 0/18\text{ V}$, $I_D = 13\text{ A}$, $T_{vj} = 175\text{ °C}$, $V_{DD} = 800\text{ V}$

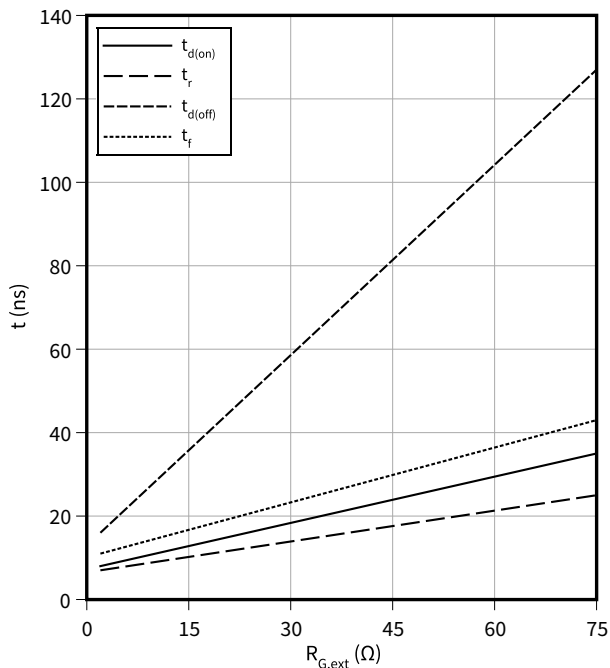


4 Characteristics diagrams

Typical switching times as a function of gate resistance, test circuit in Fig. F, 2nd device own body diode: $V_{GS} = 0\text{ V}$

$t = f(R_{G,ext})$

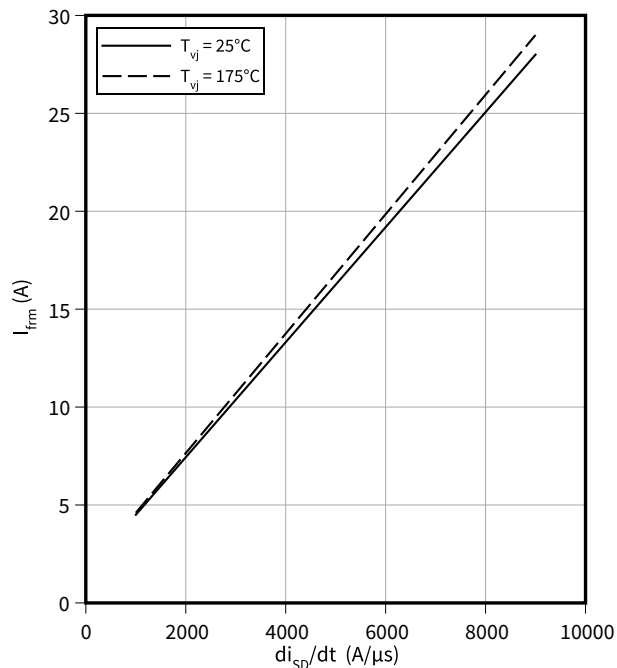
$V_{GS} = 0/20\text{ V}$, $I_D = 13\text{ A}$, $T_{vj} = 175\text{ °C}$, $V_{DD} = 800\text{ V}$



Typical reverse recovery current as a function of reverse drain current slope, test circuit in Fig. F, 2nd device own body diode: $V_{GS} = 0\text{ V}$

$I_{frm} = f(di_{SD}/dt)$

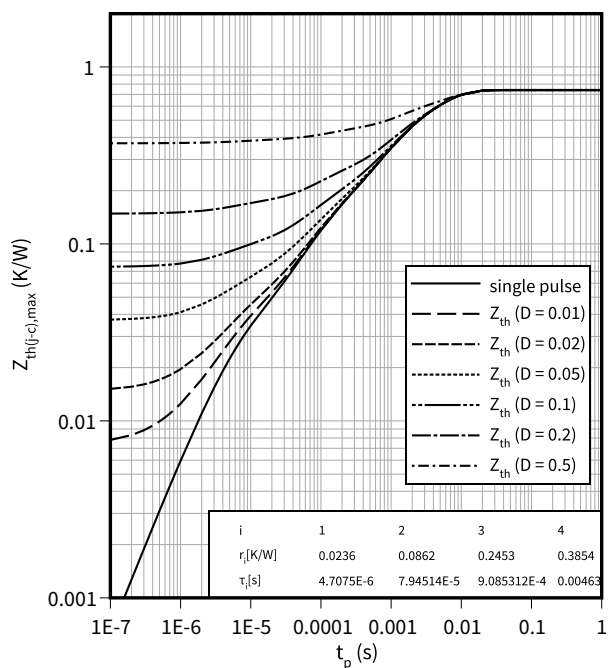
$V_{GS} = 0/20\text{ V}$, $I_{SD} = 13\text{ A}$, $V_{DD} = 800\text{ V}$



Max. transient thermal impedance (MOSFET/diode)

$Z_{th(j-c),max} = f(t_p)$

$D = t_p/T$



5 Package outlines

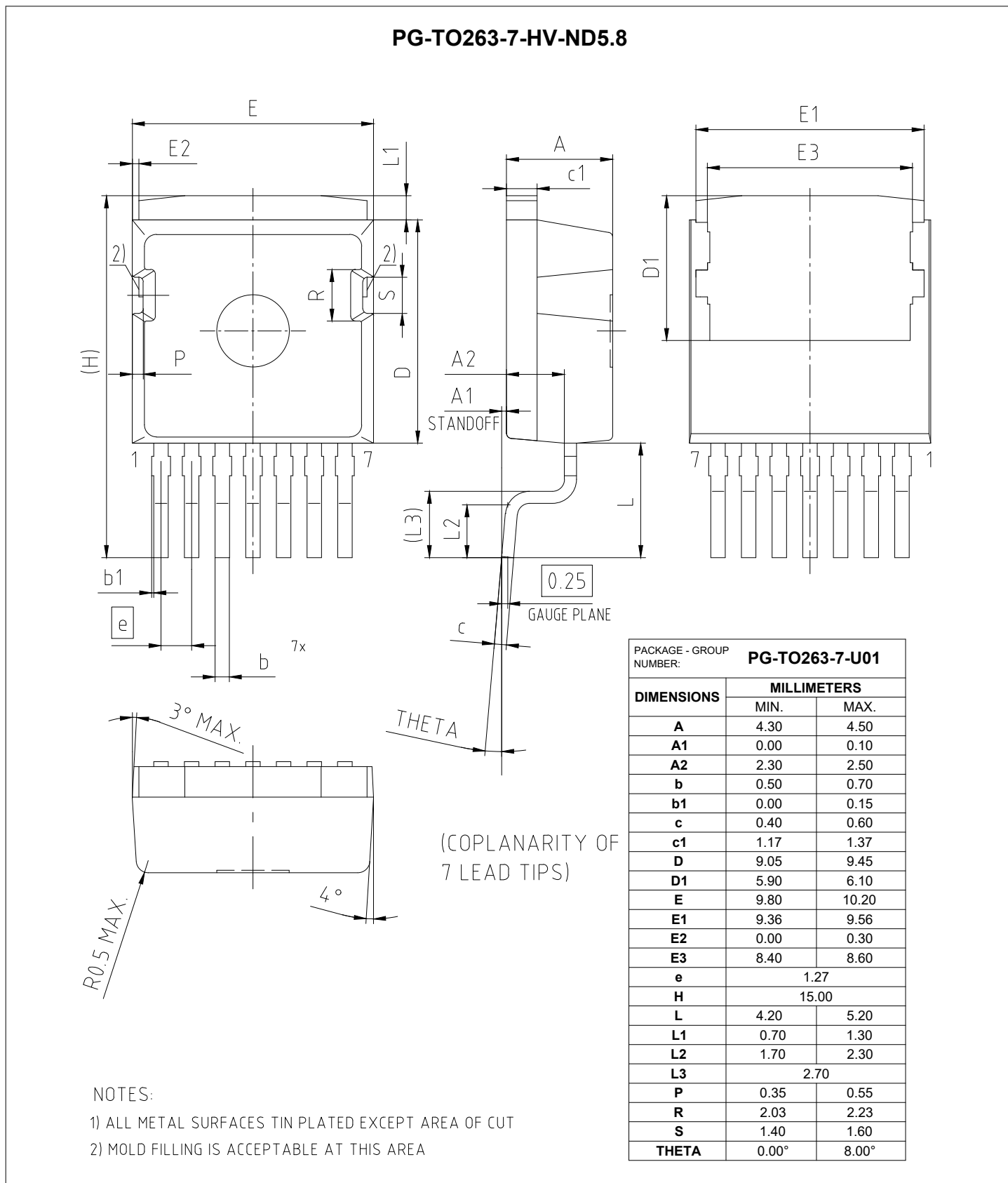


Figure 1

6 Testing conditions

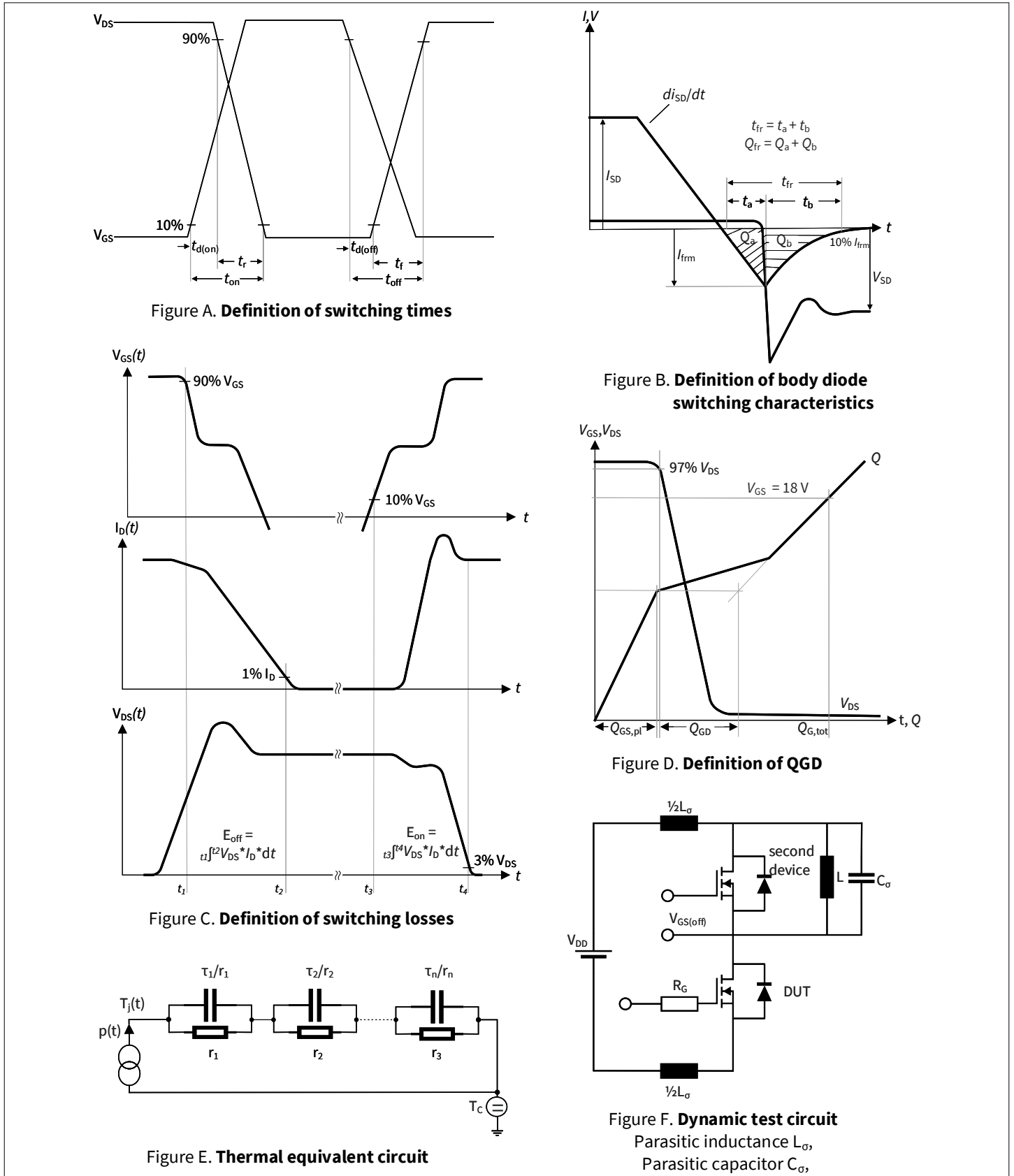


Figure 2

Revision history

Document revision	Date of release	Description of changes
0.10	2022-12-08	Preliminary datasheet
0.20	2022-12-09	Update of "Drain-source on-state resistance", value ' Max. ' for 25°C, in Table 4 "Characteristic values"
1.00	2023-05-16	Final datasheet

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Document reference

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